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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 123457			APPLICATION NO. 10/537,513			
INFORMATION DISCLOSURE STATEMENT										
(Use several sheets if necessary)				APPLICANT(S) Susumu NODA et al.						
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U.S. PATENT DOCUMENTS										
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Date: March 13, 2007

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